Search Notes				

Application/Control No.
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Applicant(s)/Patent under Reexamination

09/611,158 Examiner FLOYD ET AL. Art Unit

Jungwon Chang

2154

SEARCHED					
Class	Subclass	Date	Examiner		
709	246	10/14/2005	JWC		
709	217	10/14/2005	JWC		
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INTERFERENCE SEARCHED					
Class	Subclass	Date	Examiner		
709	246	10/14/2005	JMC		
709	217	10/14/2005	JMC		
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SEARCH NOTES (INCLUDING SEARCH STRATEGY)		
	DATE	EXMR
East text NPL: Google ACM IEEE search report attached	10/14/2005	JWC
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